# Boost Converter Stage in APM16 Series for Multiphase and Semi-Bridgeless PFC with SiC Diodes

# FAM65CR51AXZ1, FAM65CR51AXZ2

#### **Features**

- Integrated SIP or DIP Boost Converter Stage Power Module for On-board Charger (OBC) in EV or PHEV
- 5 kV/1 sec Electrically Isolated Substrate for Easy Assembly
- Creepage and Clearance per IEC60664–1, IEC 60950–1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94V-0 Compliant
- Automotive Qualified per AEC Q101 and AQG324 Guidelines
- Improved Performance with SiC Diodes

## **Applications**

• PFC Stage of an On-board Charger in PHEV or EV

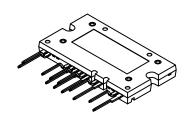
## **Benefits**

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO<sub>2</sub> Emission
- Simplified Assembly, Optimized Layout, High Level of Integration, and Improved Thermal Performance

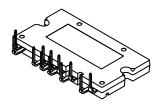


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APMCD-A16 12 LEAD CASE MODGG



APMCD-B16 12 LEAD CASE MODGK

## **MARKING DIAGRAM**

XXXXXXXXXX ZZZ ATYWW NNNNNNN

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year W = Work Week NNN = Serial Number

## **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 2 of this data sheet.

## **ORDERING INFORMATION**

Part Number	Package	Lead Forming	DBC Material	Pb-Free and RoHS Compliant	Operating Temperature (T <sub>A</sub> )	Packing Method
FAM65CR51AXZ1	APM16-CDA	Y-Shape	ALN	Yes	−40°C ~ 125°C	Tube
FAM65CR51AXZ2	APM16-CDB	L-Shape	ALN	Yes	–40°C ∼ 125°C	Tube

## **Pin Configuration and Description**

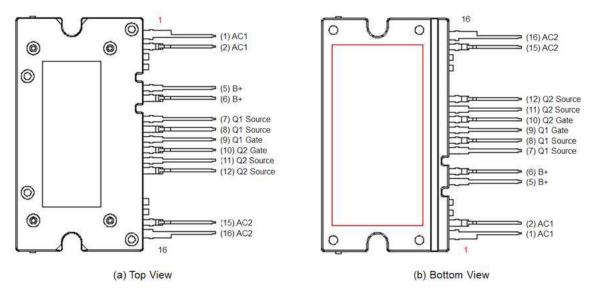


Figure 1. Pin Configuration

**Table 1. PIN DESCRIPTION** 

Pin Number	Pin Name	Pin Description
1, 2	AC1	Phase 1 Leg of the PFC Bridge
3	NC	Not Connected
4	NC	Not Connected
5, 6	B+	Positive Battery Terminal
7, 8	Q1 Source	Source Terminal of Q1
9	Q1 Gate	Gate Terminal of Q1
10	Q2 Gate	Gate Terminal of Q2
11, 12	Q2 Source	Source Terminal of Q2
13	NC	Not Connected
14	NC	Not Connected
15, 16	AC2	Phase 2 Leg of the PFC Bridge

## INTERNAL EQUIVALENT CIRCUIT

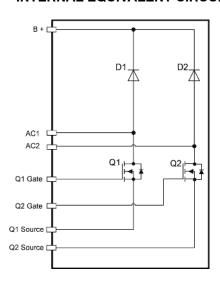


Figure 2. Internal Block Diagram

Table 2. ABSOLUTE MAXIMUM RATINGS OF MOSFET (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Max	Unit
V <sub>DS</sub> (Q1~Q2)	Drain-to-Source Voltage	650	V
V <sub>GS</sub> (Q1~Q2)	Gate-to-Source Voltage	±20	V
I <sub>D</sub> (Q1~Q2)	Drain Current Continuous (T <sub>C</sub> = 25°C, V <sub>GS</sub> = 10 V) (Note 1)	64	Α
	Drain Current Continuous (T <sub>C</sub> = 100°C, V <sub>GS</sub> = 10 V) (Note 1)	40	Α
E <sub>AS</sub> (Q1~Q2)	Single Pulse Avalanche Energy (Note 2)	623	mJ
P <sub>D</sub>	Power Dissipation (Note 1)	463	W
$T_J$	Maximum Junction Temperature	-55 to +150	°C
T <sub>C</sub>	Maximum Case Temperature	-40 to +125	°C
T <sub>STG</sub>	Storage Temperature	-40 to +125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## **DBC Substrate**

0.63 mm ALN alumina with 0.3 mm copper on both sides. DBC substrate is NOT nickel plated.

## **Lead Frame**

OFC copper alloy, 0.50 mm thick. Plated with 8  $\mu$ m to 25.4  $\mu$ m thick Matte Tin

## Flammability Information

All materials present in the power module meet UL flammability rating class 94V–0.

## **Compliance to RoHS Directives**

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

#### Solder

Solder used is a lead free SnAgCu alloy.

Solder presents high risk to melt at temperature beyond 210°C. Base of the leads, at the interface with the package body, should not be exposed to more than 200°C during mounting on the PCB or during welding to prevent the re-melting of the solder joints.

<sup>1.</sup> Maximum continuous current and power, without switching losses, to reach  $T_J = 150^{\circ}\text{C}$  respectively at  $T_C = 25^{\circ}\text{C}$  and  $T_C = 100^{\circ}\text{C}$ ; defined by design based on MOSFET  $R_{DS(ON)}$  and  $R_{\theta JC}$  and not subject to production test

<sup>2.</sup> Starting  $T_J = 25^{\circ}C$ ,  $I_{AS} = 6.5$  A,  $R_G = 25$   $\Omega$ 

Table 3. ELECTRICAL SPECIFICATIONS OF MOSFET (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	650	-	-	V
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 3.3 \text{ mA}$	3.0	-	5.0	V
R <sub>DS(ON)</sub> Q1	Q1 Low Side MOSFET	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A	-	44	51	mΩ
R <sub>DS(ON)</sub> Q2	Q2 Low Side MOSFET		-	44	51	mΩ
R <sub>DS(ON)</sub> Q1	Q1 Low Side MOSFET	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 125°C (Note 3)	-	79	-	mΩ
R <sub>DS(ON)</sub> Q2	Q2 Low Side MOSFET		-	79	-	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 20 A (Note 3)	-	30	-	S
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-100	-	+100	nA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	-	-	10	μΑ
DYNAMIC CHA	ARACTERISTICS (Note 3)					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V	-	4864	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0 V f = 1 MHz	-	109	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	I = I IVIDZ	-	16	-	pF
C <sub>oss(eff)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 to 520 V V <sub>GS</sub> = 0 V	-	652	-	pF
$R_g$	Gate Resistance	f = 1 MHz	-	2	-	Ω
Q <sub>g(tot)</sub>	Total Gate Charge	V <sub>DS</sub> = 380 V	-	123	-	nC
$Q_{gs}$	Gate-to-Source Gate Charge	I <sub>D</sub> = 20 A V <sub>GS</sub> = 0 to 10 V	-	37.5	-	nC
Q <sub>gd</sub>	Gate-to-Drain "Miller" Charge	V <sub>GS</sub> = 0 to 10 V	-	49	-	nC
SWITCHING C	HARACTERISTICS (Note 3)					•
t <sub>on</sub>	Turn-on Time	V <sub>DS</sub> = 400 V	-	87	-	ns
t <sub>d(on)</sub>	Turn-on Delay Time	I <sub>D</sub> = 20 A	-	47	-	ns
t <sub>r</sub>	Turn-on Rise Time	$V_{GS} = 10 \text{ V}$ $R_G = 4.7 \text{ Ohm}$	-	43	-	ns
t <sub>off</sub>	Turn-off Time	_	_	146	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time		-	118	-	ns
t <sub>f</sub>	Turn-off Fall Time		_	29	-	ns
BODY DIODE	CHARACTERISTICS					
V <sub>SD</sub>	Source-to-Drain Diode Voltage	$I_{SD} = 20 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.95	-	V
T <sub>rr</sub>	Reverse Recovery Time	V <sub>DS</sub> = 520 V, I <sub>D</sub> = 20 A,	-	133	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	d <sub>I</sub> /d <sub>t</sub> = 100 A/μs (Note 3)	-	669	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Defined by design, not subject to production test

Table 4. ABSOLUTE MAXIMUM RATINGS OF THE BOOST DIODE ( $T_J = 25^{\circ}C$ , Unless Otherwise Specified)

Symbol	Parameter	Rating	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage (Note 4)	650	V
E <sub>AS</sub>	Avalanche Energy (17 A, 1 mH)	144	mJ
I <sub>F</sub>	Continuous Rectified Forward Current, T <sub>C</sub> < 148°C	30	Α
I <sub>F,MAX</sub>	Non-Repetitive Forward Surge Current, T <sub>C</sub> = 25°C, 10 μs	1100	Α
I <sub>F,MAX</sub>	Non-Repetitive Forward Surge Current, T <sub>C</sub> = 150°C, 10 μs	1000	Α
I <sub>FSM</sub>	Non-Repetitive Peak Surge Current (Sine Half Wave, Tp = 8.3 ms)	110	Α
$P_{D}$	Power Dissipation (T <sub>C</sub> = 25°C)	166	W
TJ	Maximum Junction Temperature	-55 to +175	°C
T <sub>C</sub>	Maximum Case Temperature	-40 to +125	°C
T <sub>STG</sub>	Storage Temperature	-40 to +125	°C

<sup>4.</sup>  $V_{RRM}$  and  $I_F$  value referenced to TO220-2L Auto Qualified Package Device FFSP3065B\_F085

Table 5. ELECTRICAL SPECIFICATIONS OF THE BOOST DIODE (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Test Cond	itions	Min	Тур	Max	Unit
$V_{DC}$	DC Blocking Voltage	I <sub>R</sub> = 200 μA	T <sub>C</sub> = 25°C	650	-	_	V
V <sub>F</sub>	Instantaneous Forward Voltage	I <sub>F</sub> = 30 A	T <sub>C</sub> = 25°C	-	1.38	1.7	V
			T <sub>C</sub> = 125°C	-	1.6	2.0	V
			T <sub>C</sub> = 175°C	-	1.72	2.4	V
I <sub>R</sub>	Instantaneous Reverse Current	V <sub>R</sub> = 650 V	T <sub>C</sub> = 25°C	-	0.5	40	μΑ
			T <sub>C</sub> = 125°C	-	1.0	80	μΑ
			T <sub>C</sub> = 175°C	-	2.0	160	μΑ
$Q_{C}$	Total Capacitive Charge	V <sub>R</sub> = 400 V	T <sub>C</sub> = 25°C	-	43	_	nC
С	Total Capacitance	V <sub>R</sub> = 1 V	f = 100 kHz		1280		pF
		V <sub>R</sub> = 200 V	f = 100 kHz		139		
		V <sub>R</sub> = 400 V	f = 100 kHz		108		

## **Table 6. THERMAL RESISTANCE**

	Parameters			Max	Unit
R <sub>0</sub> JC (per MOSFET chip)	Q1,Q2 Thermal Resistance Junction-to-Case (Note 5)	-	0.19	0.27	°C/W
$R_{\theta JS}$ (per MOSFET chip)	Q1,Q2 Thermal Resistance Junction-to-Sink (Note 6)	-	0.61	-	°C/W
R <sub>θJC</sub> (per DIODE chip)	D1,D2 Thermal Resistance Junction-to-Case (Note 5)	_	0.7	0.9	°C/W
R <sub>0JS</sub> (per DIODE chip)	D1,D2 Thermal Resistance Junction-to-Sink (Note 6)	_	1.73	Ī	°C/W

<sup>5.</sup> Test method compliant with MIL STD 883-1012.1, from case temperature under the chip to case temperature measured below the package at the chip center, Cosmetic oxidation and discoloration on the DBC surface allowed

6. Defined by thermal simulation assuming the module is mounted on a 5 mm Al–360 die casting material with 30 um of 1.8 W/mK thermal

 Table 7. ISOLATION (Isolation resistance at tested voltage between the base plate and to control pins or power terminals.)

Test	Test Conditions	Isolation Resistance	Unit
Leakage @ Isolation Voltage (Hi-Pot)	V <sub>AC</sub> = 5 kV, 50 Hz	100M <	Ω

interface material

# **PARAMETER DEFINITIONS**

# Reference to Table 3: Parameter of MOSFET Electrical Specifications

BV <sub>DSS</sub>	Q1, Q2 MOSFET Drain-to-Source Breakdown Voltage The maximum drain-to-source voltage the MOSFET can endure without the avalanche breakdown of the body- drain P-N junction in off state. The measurement conditions are to be found in Table 3. The typ. Temperature behavior is described in Figure 13
V <sub>GS(th)</sub>	Q1, Q2 MOSFET Gate to Source Threshold Voltage  The gate-to-source voltage measurement is triggered by a threshold ID current given in conditions at Table 4.  The typ. Temperature behavior can be found in Figure 10
R <sub>DS(ON)</sub>	Q1, Q2 MOSFET On Resistance RDS(on) is the total resistance between the source and the drain during the on state. The measurement conditions are to be found in Table 3. The typ behavior can be found in Figure 11 and Figure 12 as well as Figure 17
9FS	Q1, Q2 MOSFET Forward Transconductance Transconductance is the gain in the MOSFET, expressed in the Equation below. It describes the change in drain current by the change in the gate–source bias voltage: $g_{fs} = [\Delta I_{DS} / \Delta V_{GS}]_{VDS}$
I <sub>GSS</sub>	Q1, Q2 MOSFET Gate-to-Source Leakage Current The current flowing from Gate to Source at the maximum allowed VGS The measurement conditions are described in the Table 3.
I <sub>DSS</sub>	Q1, Q2 MOSFET Drain-to-Source Leakage Current  Drain – Source current is measured in off state while providing the maximum allowed drain-to-source voltage and the gate is shorted to the source.  IDSS has a positive temperature coefficient.

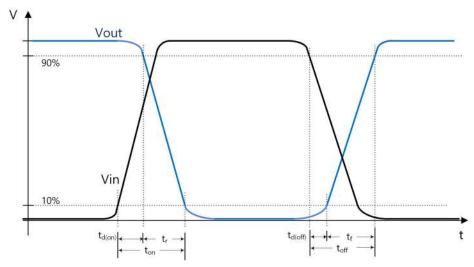


Figure 3. Timing Measurement Variable Definition

## Table 8. PARAMETER OF SWITCHING CHARACTERISTICS

Turn-On Delay (t <sub>d(on)</sub> )	This is the time needed to charge the input capacitance, Ciss, before the load current ID starts flowing. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Rise Time (t <sub>r</sub> )	The rise time is the time to discharge output capacitance, Coss. After that time the MOSFET conducts the given load current ID. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Turn-On Time (ton)	Is the sum of turn-on-delay and rise time
Turn-Off Delay (t <sub>d(off)</sub> )	td(off) is the time to discharge Ciss after the MOSFET is turned off. During this time the load current ID is still flowing The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Fall Time (t <sub>f</sub> )	The fall time, tf, is the time to charge the output capacitance, Coss.  During this time the load current drops down and the voltage VDS rises accordingly.  The measurement conditions are described in the Table 3.  For signal definition please check Figure 3 above.
Turn-Off Time (toff):	Is the sum of turn-off-delay and fall time

## **TYPICAL CHARACTERISTICS - MOSFETs**

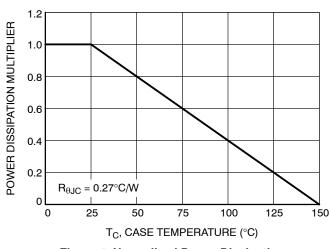


Figure 4. Normalized Power Dissipation vs.

Case Temperature

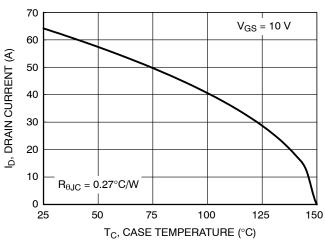


Figure 5. Maximum Continuous  $I_D$  vs. Case Temperature

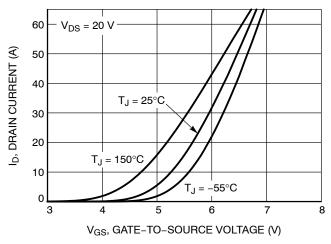


Figure 6. Transfer Characteristics

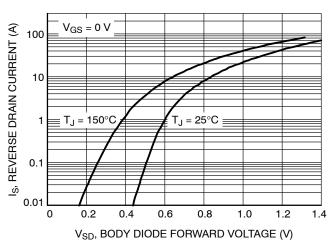


Figure 7. Forward Diode

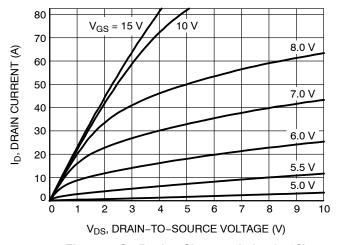


Figure 8. On Region Characteristics (25°C)

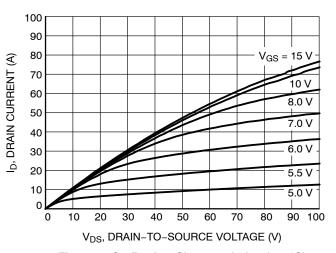
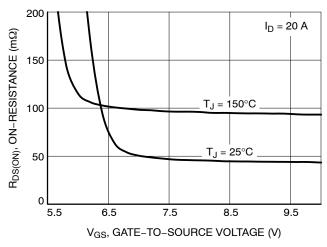


Figure 9. On Region Characteristics (150°C)

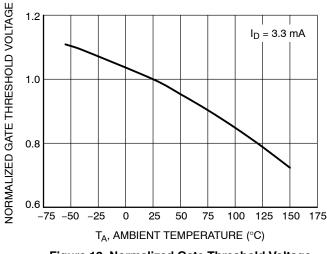
## TYPICAL CHARACTERISTICS - MOSFETs



 $I_D = 20 A$ R<sub>DS(ON)</sub>, NORMALIZED DRAIN-TO-SOURCE ON-RESISTANCE V<sub>GS</sub> = 10 V 2.0 1.5 1.0 0.5 -75 -50 -25 25 50 75 100 125 150 175 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 10. On-Resistance vs. Gate-to-Source Voltage

Figure 11. R<sub>DS(norm)</sub> vs. Junction Temperature



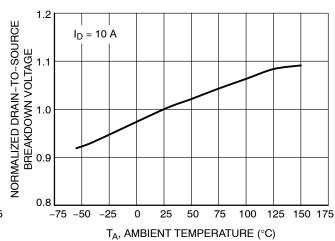
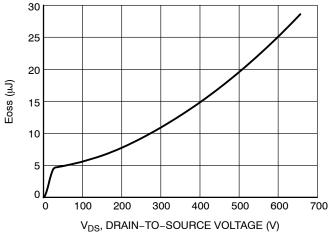


Figure 12. Normalized Gate Threshold Voltage vs. Temperature

Figure 13. Normalized Breakdown Voltage vs.
Temperature



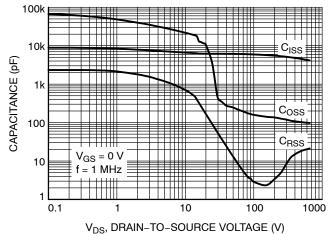


Figure 14. Eoss vs. Drain-to-Source Voltage

Figure 15. Capacitance Variation

## TYPICAL CHARACTERISTICS - MOSFETs

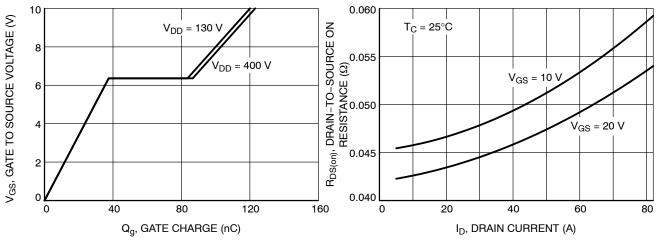


Figure 16. Gate Charge Characteristics

Figure 17. ON-Resistance Variation with Drain Current and Gate Voltage

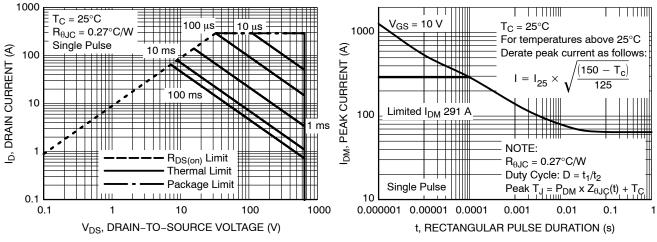


Figure 18. Safe Operating Area

Figure 19. Peak Current Capability

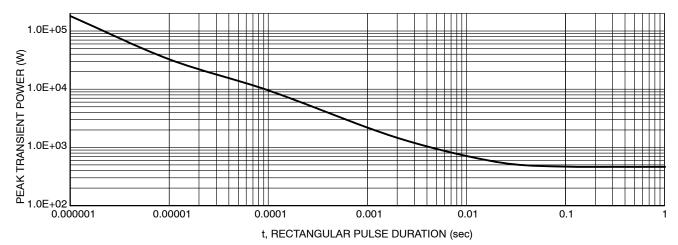


Figure 20. Peak Power

## **TYPICAL CHARACTERISTICS - DIODES**

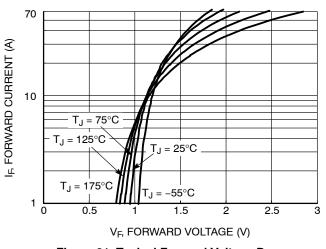


Figure 21. Typical Forward Voltage Drop vs. Forward Current

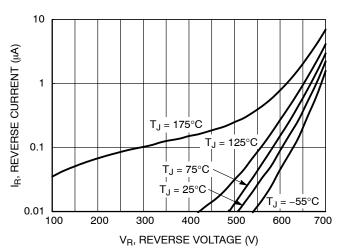


Figure 22. Typical Reverse Current vs. Reverse Voltage

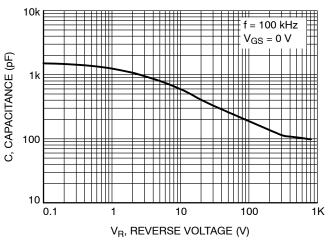


Figure 23. Capacitance vs. Reverse Voltage

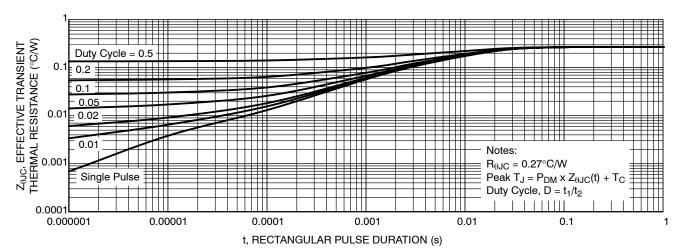
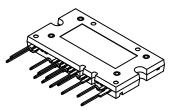


Figure 24. Transient Thermal Impedance

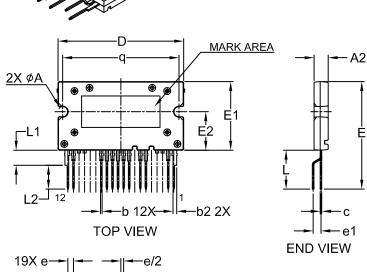


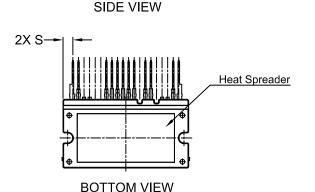


APMCD-A16 / 12LD, AUTOMOTIVE MODULE

CASE MODGG ISSUE C

**DATE 03 NOV 2021** 





## NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS				
DIM	MIN.	NOM.	MAX.		
A2	4.30	4.50	4.70		
b	0.45	0.50	0.60		
b2	1.15	1.20	1.30		
С	0.45	0.50	0.60		
D	39.90	40.10	40.30		
Е	33.80	34.30	34.80		
E1	21.70	21.90	22.10		
E2	12.10	12.30	12.50		
е	1.478	1.778	2.078		
e1	2.20	2.50	2.80		
L	12.10	12.40	12.70		
L1		4.80 REF			
L2	7.30	7.60	7.90		
q	36.85	37.10	37.35		
S	3.159 REF				
ΦA	3.00	3.20	3.40		

# GENERIC MARKING DIAGRAM\*

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year WW = Work

WW = Work Week
NNN = Serial Number

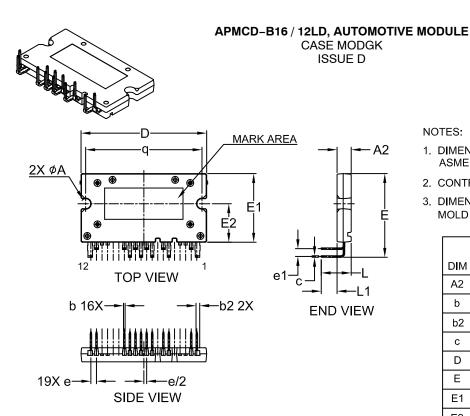
\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

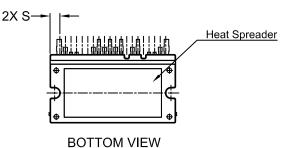
DOCUMENT NUMBER:	98AON94738G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	APMCD-A16 / 12LD. AUTO	D-A16 / 12LD. AUTOMOTIVE MODULE		

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**DATE 04 NOV 2021** 





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	MILLIMETERS		
DIM	MIN.	NOM.	MAX.
A2	4.30	4.50	4.70
b	0.45	0.50	0.60
b2	1.15	1.20	1.30
С	0.45	0.50	0.60
D	39.90	40.10	40.30
Е	26.20	26.70	27.20
E1	21.70	21.90	22.10
E2	12.10	12.30	12.50
е	1.478	1.778	2.078
e1	2.20	2.50	2.80
٦	9.20	9.55	9.90
L1	4.70	5.05	5.40
q	36.85	37.10	37.35
S	3.159 REF		
ΦA	3.00	3.20	3.40

## **GENERIC MARKING DIAGRAM\***

XXXXXXXXXXXXXXX **777 ATYWW** NNNNNN

XXXX = Specific Device Code

ZZZ = Lot ID

ΑT = Assembly & Test Location

Υ = Year W = Work Week NNN = Serial Number \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	DESCRIPTION: APMCD-B16 / 12LD, AUTOMOTIVE MODULE		PAGE 1 OF 1

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